

Search Notes

Application/Control No.

10/525,244

Examiner

G. Nagesh Rao

Applicant(s)/Patent under
Reexamination

HOSHI ET AL.

Art Unit

1722

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor Search	2/26/2007	GNR
Text Search (striations, single crystal, silicon, nanotopology, nanotopography, etc...)	2/26/2007	GNR
PG Pub and Derwent Search	2/26/2007	GNR